AMENDMENTS TO THE CLAIMS

Please cancel claims 1, 3-6, 9-10, 12, 21-23, 25, 27-28 and 32-40. Please amend claims 2, 7, 11, 15-20, 24, 26, 29 and 31. No new matter is believed to be introduced as a result of the aforementioned amendments. The following listing of claims replaces all prior versions and listings of claims in this application.

1. (Canceled)

2. (Currently amended) A vertical cavity surface emitting laser according to claim [[1]] 7, wherein the modulation layer is doped with a concentration greater than 1x10¹⁹ cm⁻³.

3.-6. (Canceled)

7. (Currently amended) A vertical cavity surface emitting laser according to claim 6, wherein the modulation doped layer is an A1InAs layer epitaxially grown as a digital alloy of p-type doped A1As and InAs comprising:

a substrate;

a first mirror stack over the substrate;

an active region having a plurality of quantum wells over the first mirror stack; a tunnel junction over the active region, the tunnel junction including:

a p-layer that includes a modulation doped layer comprising an AlInAs layer epitaxially grown as a digital alloy of p-type doped AlAs and InAs; and

an n-layer that includes an n-layer of a compound selected from the group consisting of InP, A1InAs, A1InGaAs, InGaAsP, GaAs, A1As, A1GaAs, InGaAs, A1GaAsSb, GaAsSb, A1AsSb, A1PSb, GaPSb, A1GaPSb, and combinations thereof; and

a second mirror stack over the tunnel junction.

8. (Original) A vertical cavity surface emitting laser according to claim 7, wherein the p-type AlAs layer is doped with carbon to a concentration greater than 1×10^{19} cm⁻³, and wherein an effective doping concentration of the modulation doped layer is greater than 1×10^{19} cm⁻³.

9.-10. (Canceled)

11. (Currently Amended) A vertical cavity surface emitting laser according to claim 10, wherein the modulation doped layer includes a SiAs layer and an A1GaInAs layer. comprising:

a substrate;

a first mirror stack over the substrate;

an active region having a plurality of quantum wells over the first mirror stack;

a tunnel junction over the active region, the tunnel junction including:

an n-layer that includes a modulation doped layer comprising an SiAs layer and an A1GaInAs layer; and

a p-layer that includes a p-layer of a compound selected from the group consisting of InP, A1InAs, A1InGaAs, InGaAsP, GaAs, A1As, A1GaAs, InGaAs, A1GaAsSb, GaAsSb, A1AsSb, A1PSb, GaPSb, A1GaPSb, and combinations thereof; and

a second mirror stack over the tunnel junction.

12. (Canceled)

- 13. (Original) A vertical cavity surface emitting laser according to claim 11, wherein the thickness of the SiAs layer is about 1/1000 of the A1GaInAs layer.
- 14. (Original) A vertical cavity surface emitting laser according to claim 11, wherein an effective doping concentration of the modulation doped layer is greater than 1×10^{19} cm⁻³.

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- 15. (Currently amended) A vertical cavity surface emitting laser according to claim [[1]] 7, further including an n-type spacer adjacent the active region, and wherein the first mirror stack is an n-type DBR.
- 16. (Currently amended) A vertical cavity surface emitting laser according to claim [[1]] 7, further including [[an]] a p-type spacer adjacent the tunnel junction, and wherein the second mirror stack is an n-type DBR.
 - 17. (Currently amended) A vertical cavity surface emitting laser according to claim [[1]] 7, further including:

an n-type bottom spacer adjacent the active region, and wherein the first mirror stack is an n-type DBR; and

[[an]] a p-type top spacer adjacent the tunnel junction, wherein the first and second mirror stacks are each an n-type DBR.

- 18. (Currently amended) A vertical cavity surface emitting laser according to claim [[5]] 7, wherein the p-layer is doped with carbon with a concentration greater than lx10¹⁹ cm⁻³.
 - 19. (Currently amended) A vertical cavity surface emitting laser according to claim [[1]] 7, wherein the active region includes one of InGaAsP and AlInGaAs.
 - 20. (Currently amended) A vertical cavity surface emitting laser according to claim [[1]] 7, wherein the first and second mirror stacks are lower and upper mirror stacks, respectively.

21.-23. (Canceled)

24. (Currently amended) A tunnel junction according to claim [[23]] $\underline{29}$, wherein the modulation-doped layer is doped with an effective carrier concentration greater than 1×10^{19} cm⁻³.

25. (Canceled)

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26. (Currently amended) A tunnel junction according to claim [[25]] <u>29</u>, wherein a total thickness of the first layer and the second modulation-doped layer is in a range of about 0.lnm ~ about 2nm.

27. - 28. (Canceled)

- 29. (Currently amended) A tunnel junction according to claim 23, wherein the modulation doped layer is including a modulation doped layer that comprises an AlInAs layer epitaxially grown as a digital alloy of p-type doped AlAs and InAs.
- 30. (Original) A tunnel junction according to claim 29, wherein the p-type AlAs layer is doped with carbon to a concentration greater than $1x10^{19}$ cm⁻³, and wherein an effective doping concentration of the modulation doped layer is greater than $1x10^{19}$ cm⁻³.
- 31. **(Currently amended)** A tunnel junction according to claim [[23]] <u>29</u>, an n-layer of wherein the tunnel junction includes the modulation doped layer an n-type layer.

32.-40. (Canceled)